RESPONSE UNDER 37 CFR 1.116-EXPEDITED PROCEDURE EXAMINING GROUP 1772"

Docket No.: 240464US

COMMISSIONER FOR PATENTS ALEXANDRIA, VIRGINIA 22313

RE: Application Serial No.: 10/621,714

Applicants: Tomio HIRANO, et al.

Filing Date: July 18, 2003

For: GLASS SUBSTRATE AND GLASS

**CUTTING METHOD** 

Group Art Unit: 1772

Examiner: CHEVALIER, A. A.

SIR:

Attached hereto for filing are the following papers:

## REQUEST FOR RECONSIDERATION (After Final)

Our check in the amount of \$0 is attached covering any required fees. In the event any variance exists between the amount enclosed and the Patent Office charges for filing the above-noted documents, including any fees required under 37 C.F.R 1.136 for any necessary Extension of Time to make the filing of the attached documents timely, please charge or credit the difference to our Deposit Account No. 15-0030. Further, if these papers are not considered timely filed, then a petition is hereby made under 37 C.F.R. 1.136 for the necessary extension of time. A duplicate copy of this sheet is enclosed.

Respectfully submitted,

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## "RESPONSE UNDER 37 CFR 1.116-EXPEDITED PROCEDURE EXAMINING GROUP <u>177</u>2"

DOCKET NO: 240464US6

## IN THE UNITED STATES PATENT & TRADEMARK OFFICE

IN RE APPLICATION OF

:

Tomio HIRANO, et al.

: EXAMINER: CHEVALIER, A. A.

SERIAL NO: 10/621,714

:

FILED: JULY 18, 2003

: GROUP ART UNIT: 1772

FOR: GLASS SUBSTRATE AND

GLASS CUTTING METHOD

## **REQUEST FOR RECONSIDERATION**

COMMISSIONER FOR PATENTS ALEXANDRIA, VIRGINIA 22313

SIR:

In response to the Office Action dated February 22, 2006, please reconsider the above-identified application based on the following:

Remarks/Arguments begin on page 2 of this paper.